Application/Control No. Applicant(s)/Patent Under Reexamination 10/728,801 Notice of References Cited NAGAHARA ET AL. Examiner Art Unit Page 1 of 1 Sin J. Lee 1752 **U.S. PATENT DOCUMENTS** Document Number Date Country Code-Number-Kind Code MM-YYYY Name Classification US-Α В US-С US-US-D Ε US-F US-G US-Н US-US-1 US-Κ US-US-L М US-FOREIGN PATENT DOCUMENTS Document Number Date Country Code-Number-Kind Code Country MM-YYYY Name Classification JP 2000-181069 Ν 06-2000 Japan Nagahara et al. N/A 0 Ρ Q R s T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) Mahcine-Assisted English Translation for JP 2000-181069, provided by Japan Patent Office ٧ W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.